

## Robust low noise broadband pre-matched RF bipolar transistor









## **Product description**

The BFP843 is a robust low noise broadband pre-matched RF heterojunction bipolar transistor (HBT).



### **Feature list**

- Unique combination of high end RF performance and robustness: 20 dBm maximum RF input power,
   1.5 kV HBM ESD hardness
- High transition frequency enables best in class noise performance at high frequencies:  $NF_{min} = 1.2 \, dB$  at 5.5 GHz, 1.8 V, 8 mA
- High gain  $G_{\text{ma}} = 17 \text{ dB at } 5.5 \text{ GHz}, 1.8 \text{ V}, 15 \text{ mA}$
- OIP<sub>3</sub> = 19.5 dBm at 5.5 GHz, 1.8 V, 15 mA
- Suitable for low voltage applications e.g.  $V_{CC} = 1.2 \text{ V}$  and 1.8 V (2.85 V, 3.3 V, 3.6 V require a corresponding collector resistor)

### **Product validation**

Qualified for industrial applications according to the relevant tests of JEDEC47/20/22.

## **Potential applications**

- WLAN, WiMAX and UWB
- Satellite communication systems: satellite radio (SDARs, DAB) and navigation systems (e.g. GPS, GLONASS, BeiDou, Galileo)

### **Device information**

#### Table 1 Part information

Product name / Ordering code	Package	Pin co	nfigura	tion		Marking	Pieces / Reel
BFP843 / BFP843H6327XTSA1	SOT343	1 = B	2 = E	3 = C	4 = E	T2s	3000

Attention: ESD (Electrostatic discharge) sensitive device, observe handling precautions

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**Absolute maximum ratings** 

## 1 Absolute maximum ratings

Table 2 Absolute maximum ratings at  $T_A = 25$  °C (unless otherwise specified)

Parameter	Symbol	Va	lues	Unit	Note or test condition
		Min.	Max.		
Collector emitter voltage	$V_{CEO}$	_	2.25	٧	Open base
			2.0		T <sub>A</sub> = -55 °C, open base
Collector emitter voltage <sup>1)</sup>	V <sub>CES</sub>		2.25		E-B short circuited
			2.0		T <sub>A</sub> = -55 °C, E-B short circuited
Collector base voltage <sup>2)</sup>	$V_{CBO}$		2.9		Open emitter
			2.6		$T_{\rm A}$ = -55 °C, open emitter
Base current	I <sub>B</sub>	-5	5	mA	-
Collector current	I <sub>C</sub>	_	55		
RF input power	$P_{RFin}$	_	20	dBm	
ESD stress pulse	$V_{ESD}$	-1.5	1.5	kV	HBM, all pins, acc. to JESD22-A114
Total power dissipation <sup>3)</sup>	P <sub>tot</sub>	_	125	mW	<i>T</i> <sub>S</sub> ≤ 99 °C
Junction temperature	TJ	_	150	°C	-
Storage temperature	$T_{Stg}$	-55			

Attention: Stresses above the max. values listed here may cause permanent damage to the device.

Exposure to absolute maximum rating conditions for extended periods may affect device reliability. Exceeding only one of these values may cause irreversible damage to the integrated circuit.

 $<sup>^{1}</sup>$   $V_{\text{CES}}$  is similar to  $V_{\text{CEO}}$  due to design.

 $V_{\rm CBO}$  is similar to  $V_{\rm CEO}$  due to design.

 $T_S$  is the soldering point temperature.  $T_S$  is measured on the emitter lead at the soldering point of the PCB.



Thermal characteristics

## 2 Thermal characteristics

Table 3 Thermal resistance

Parameter	Symbol	Values			Unit	Note or test condition
		Min.	Тур.	Max.		
Junction - soldering point	R <sub>thJS</sub>	_	405	_	K/W	_

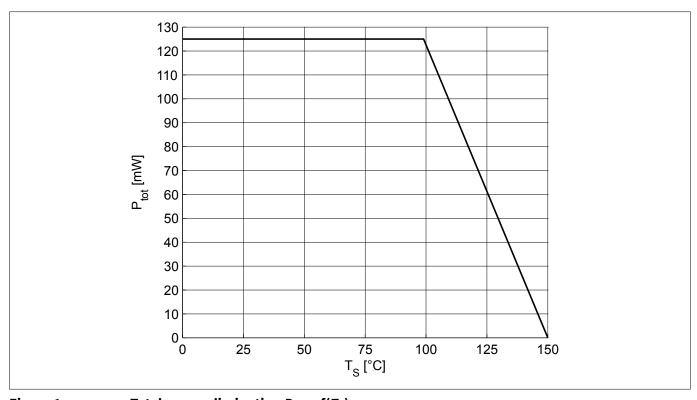


Figure 1 Total power dissipation  $P_{\text{tot}} = f(T_S)$ 



### **Electrical characteristics**

## 3 Electrical characteristics

### 3.1 DC characteristics

Table 4 DC characteristics at  $T_A = 25$  °C

Parameter	Symbol		Values	<b>;</b>	Unit	Note or test condition
		Min.	Тур.	Max.		
Collector emitter breakdown voltage	V <sub>(BR)CEO</sub>	2.25	2.6	-	V	$I_C = 1 \text{ mA}, I_B = 0,$ open base
Collector emitter leakage current	I <sub>CES</sub>	_	_	400 1)	nA	$V_{CE} = 1.5 \text{ V}, V_{BE} = 0,$ E-B short circuited
Collector base leakage current	I <sub>CBO</sub>			400 <sup>1)</sup>		$V_{\text{CB}} = 1.5 \text{ V}, I_{\text{E}} = 0,$ open emitter
Emitter base leakage current	I <sub>EBO</sub>			10 <sup>1)</sup>	μΑ	$V_{\rm EB}$ = 0.5 V, $I_{\rm C}$ = 0, open collector
DC current gain	h <sub>FE</sub>	150	260	450	-	$V_{CE}$ = 1.8 V, $I_{C}$ = 15 mA, pulse measured

### 3.2 General AC characteristics

Table 5 General AC characteristics at  $T_A = 25$  °C

Parameter	Symbol	Values		Values		Values		Note or test condition
		Min.	Тур.	Max.				
Collector base capacitance <sup>2)</sup>	C <sub>CB</sub>	_	5.23 0.06	_	pF	f = 1 MHz, f = 1 GHz,		
			0.00			$V_{CB} = 1.8 \text{ V}, V_{BE} = 0,$ emitter grounded		
Collector emitter capacitance	C <sub>CE</sub>		0.5			f = 1 MHz, $V_{CE}$ = 1.8 V, $V_{BE}$ = 0, base grounded		
Emitter base capacitance	C <sub>EB</sub>		0.73			f = 1 MHz, $V_{EB}$ = 0.4 V, $V_{CB}$ = 0, collector grounded		

Maximum values not limited by the device but by the short cycle time of the 100% test

<sup>&</sup>lt;sup>2</sup> Including integrated feedback capacitance



### **Electrical characteristics**

## 3.3 Frequency dependent AC characteristics

Measurement setup is a test fixture with Bias-T's in a 50  $\Omega$  system,  $T_{\rm A}$  = 25 °C.

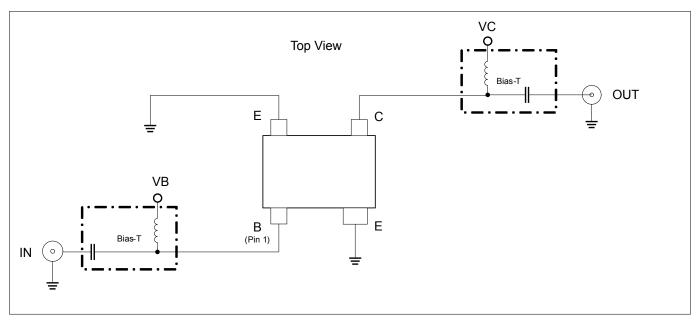


Figure 2 Testing circuit

Table 6 AC characteristics,  $V_{CE} = 1.8 \text{ V}, f = 450 \text{ MHz}$ 

Parameter	Symbol	Values			Unit	Note or test condition
		Min.	Тур.	Max.		
Power gain		_		_	dB	
Maximum power gain	G <sub>ma</sub>		24.5			$I_{\rm C} = 15  {\rm mA}$
• Transducer gain	$ S_{21} ^2$		24.5			
Noise figure						
<ul> <li>Minimum noise figure</li> </ul>	NF <sub>min</sub>		0.9			$I_{\rm C}$ = 8 mA
<ul> <li>Associated gain</li> </ul>	G <sub>ass</sub>		22			
Linearity					dBm	
<ul> <li>3rd order intercept point at output</li> </ul>	OIP <sub>3</sub>		24			$I_{\rm C} = 15 \text{ mA}, Z_{\rm S} = Z_{\rm L} = 50 \Omega$
• 1 dB gain compression point at output	OP <sub>1dB</sub>		7			

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### **Electrical characteristics**

Table 7 AC characteristics,  $V_{CE} = 1.8 \text{ V}$ , f = 900 MHz

Parameter	Symbol		Values			Note or test condition
		Min.	Тур.	Max.		
Power gain		_		_	dB	
<ul> <li>Maximum power gain</li> </ul>	G <sub>ma</sub>		24			$I_{\rm C}$ = 15 mA
<ul> <li>Transducer gain</li> </ul>	$ S_{21} ^2$		24			
Noise figure						
<ul> <li>Minimum noise figure</li> </ul>	NF <sub>min</sub>		0.9			$I_{\rm C}$ = 8 mA
<ul> <li>Associated gain</li> </ul>	G <sub>ass</sub>		22			
Linearity					dBm	
<ul> <li>3rd order intercept point at output</li> </ul>	OIP <sub>3</sub>		23.5			$I_{\rm C} = 15  \text{mA}, Z_{\rm S} = Z_{\rm L} = 50  \text{G}$
• 1 dB gain compression point at output	OP <sub>1dB</sub>		8			

## Table 8 AC characteristics, $V_{CE} = 1.8 \text{ V}, f = 1.5 \text{ GHz}$

Parameter	Symbol	Values			Unit	Note or test condition
		Min.	Тур.	Max.		
Power gain		_		_	dB	
<ul> <li>Maximum power gain</li> </ul>	G <sub>ma</sub>		23.5			$I_{\rm C} = 15  {\rm mA}$
• Transducer gain	$ S_{21} ^2$		23			
Noise figure						
<ul> <li>Minimum noise figure</li> </ul>	NF <sub>min</sub>		0.95			$I_{\rm C}$ = 8 mA
<ul> <li>Associated gain</li> </ul>	G <sub>ass</sub>		21			
Linearity					dBm	
3rd order intercept point at output	OIP <sub>3</sub>		22.5			$I_{\rm C} = 15 \text{ mA}, Z_{\rm S} = Z_{\rm L} = 50 \Omega$
• 1 dB gain compression point at output	OP <sub>1dB</sub>		6			

## Table 9 AC characteristics, $V_{CE} = 1.8 \text{ V}, f = 1.9 \text{ GHz}$

Parameter	Symbol		Values			Note or test condition	
		Min.	Тур.	Max.			
Power gain		_		_	dB		
<ul> <li>Maximum power gain</li> </ul>	G <sub>ma</sub>		22.5			$I_{\rm C} = 15  {\rm mA}$	
<ul> <li>Transducer gain</li> </ul>	$ S_{21} ^2$		22				
Noise figure							
<ul> <li>Minimum noise figure</li> </ul>	NF <sub>min</sub>		0.95			$I_{\rm C}$ = 8 mA	
<ul> <li>Associated gain</li> </ul>	G <sub>ass</sub>		20				
Linearity					dBm		
<ul> <li>3rd order intercept point at output</li> </ul>	OIP <sub>3</sub>		24			$I_{\rm C} = 15 \text{ mA}, Z_{\rm S} = Z_{\rm L} = 50 \Omega$	
• 1 dB gain compression point at output	OP <sub>1dB</sub>		8.5				

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### **Electrical characteristics**

Table 10 AC characteristics,  $V_{CE} = 1.8 \text{ V}$ , f = 2.4 GHz

Parameter	Symbol		Values			Note or test condition
		Min.	Тур.	Max.		
Power gain		_		_	dB	
<ul> <li>Maximum power gain</li> </ul>	G <sub>ma</sub>		21.5			$I_{\rm C}$ = 15 mA
<ul> <li>Transducer gain</li> </ul>	$ S_{21} ^2$		21			
Noise figure						
<ul> <li>Minimum noise figure</li> </ul>	NF <sub>min</sub>		1.0			$I_{\rm C}$ = 8 mA
<ul> <li>Associated gain</li> </ul>	G <sub>ass</sub>		19.5			
Linearity					dBm	
<ul> <li>3rd order intercept point at output</li> </ul>	OIP <sub>3</sub>		22			$I_{\rm C} = 15  \text{mA}, Z_{\rm S} = Z_{\rm L} = 50  \text{G}$
• 1 dB gain compression point at output	OP <sub>1dB</sub>		6.5			

## Table 11 AC characteristics, $V_{CE} = 1.8 \text{ V}, f = 3.5 \text{ GHz}$

Parameter	Symbol	Values			Unit	Note or test condition
		Min.	Тур.	Max.		
Power gain		_		_	dB	
<ul> <li>Maximum power gain</li> </ul>	G <sub>ma</sub>		19.5			$I_{\rm C} = 15  {\rm mA}$
• Transducer gain	$ S_{21} ^2$		19			
Noise figure						
<ul> <li>Minimum noise figure</li> </ul>	NF <sub>min</sub>		1.1			$I_{\rm C}$ = 8 mA
<ul> <li>Associated gain</li> </ul>	G <sub>ass</sub>		17.5			
Linearity					dBm	
3rd order intercept point at output	OIP <sub>3</sub>		22.5			$I_{\rm C} = 15 \text{ mA}, Z_{\rm S} = Z_{\rm L} = 50 \Omega$
• 1 dB gain compression point at output	OP <sub>1dB</sub>		7			

## Table 12 AC characteristics, $V_{CE} = 1.8 \text{ V}, f = 5.5 \text{ GHz}$

Parameter	Symbol	Values		Unit	Note or test condition	
		Min.	Тур.	Max.		
Power gain		_		_	dB	
<ul> <li>Maximum power gain</li> </ul>	G <sub>ma</sub>		17			$I_{\rm C} = 15  {\rm mA}$
Transducer gain	$ S_{21} ^2$		15.5			
Noise figure						
<ul> <li>Minimum noise figure</li> </ul>	NF <sub>min</sub>		1.2			$I_{\rm C}$ = 8 mA
Associated gain	G <sub>ass</sub>		15			
Linearity					dBm	
3rd order intercept point at output	OIP <sub>3</sub>		19.5			$I_{\rm C} = 15  {\rm mA}, Z_{\rm S} = Z_{\rm L} = 50  {\rm \Omega}$
$\bullet \hspace{0.5cm} 1 dB \ gain \ compression \ point \ at \ output$	OP <sub>1dB</sub>		4			

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### **Electrical characteristics**

Table 13 AC characteristics,  $V_{CE} = 1.8 \text{ V}$ , f = 10 GHz

Parameter	Symbol	Values			Unit	Note or test condition
		Min.	Тур.	Max.		
Power gain		_		_	dB	
Maximum power gain	G <sub>ma</sub>		13.5			$I_{\rm C} = 15  {\rm mA}$
• Transducer gain	$ S_{21} ^2$		8.5			
Noise figure						
<ul> <li>Minimum noise figure</li> </ul>	NF <sub>min</sub>		1.85			$I_{\rm C}$ = 8 mA
<ul> <li>Associated gain</li> </ul>	G <sub>ass</sub>		9			
Linearity					dBm	
<ul> <li>3rd order intercept point at output</li> </ul>	OIP <sub>3</sub>		16			$I_{\rm C} = 15 \text{ mA}, Z_{\rm S} = Z_{\rm L} = 50 \Omega$
• 1 dB gain compression point at output	OP <sub>1dB</sub>		0			

Note:

 $G_{ms} = IS_{21}/S_{12}I$  for k < 1;  $G_{ma} = IS_{21}/S_{12}I(k-(k^2-1)^{1/2})$  for k > 1. In order to get the NF<sub>min</sub> values stated in this chapter, the test fixture losses have been subtracted from all measured results. OIP<sub>3</sub> value depends on termination of all intermodulation frequency components. Termination used for this measurement is 50  $\Omega$  from 0.2 MHz to 12 GHz.



**Electrical characteristics** 

## 3.4 Characteristic DC diagrams

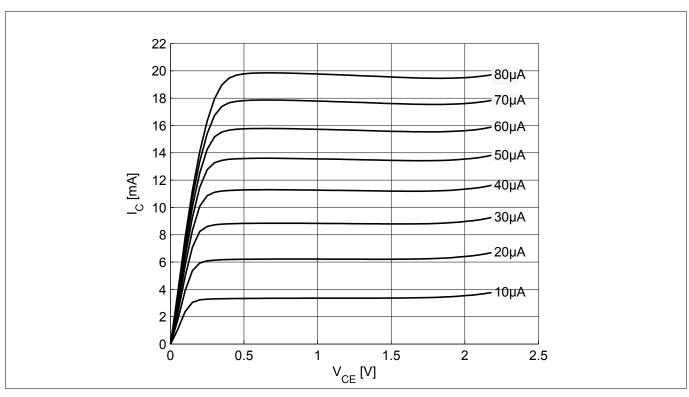


Figure 3 Collector current vs. collector emitter voltage  $I_C = f(V_{CE})$ ,  $I_B = parameter$ 

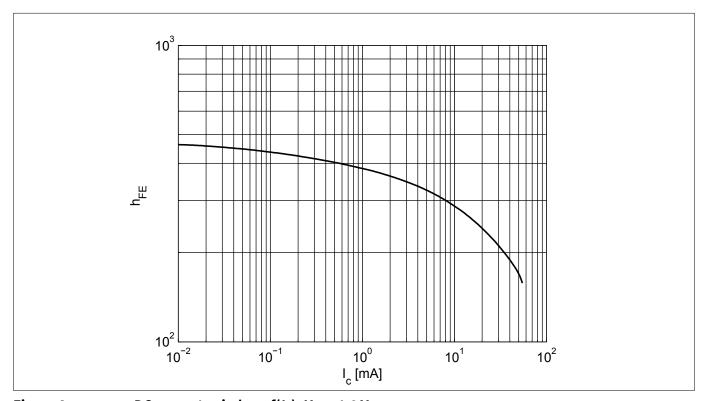


Figure 4 DC current gain  $h_{FE} = f(I_C)$ ,  $V_{CE} = 1.8 \text{ V}$ 



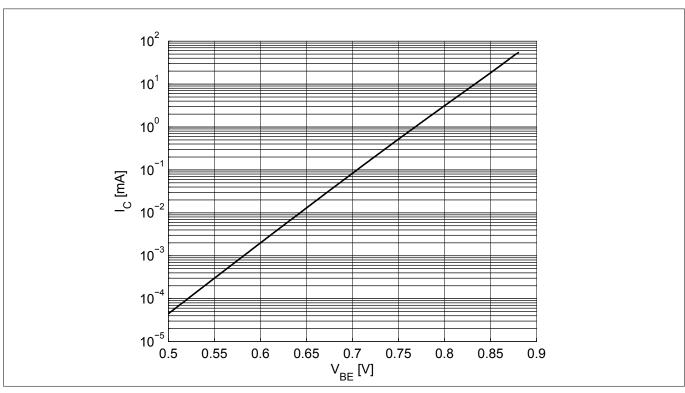


Figure 5 Collector current vs. base emitter forward voltage  $I_C = f(V_{BE})$ ,  $V_{CE} = 1.8 \text{ V}$ 

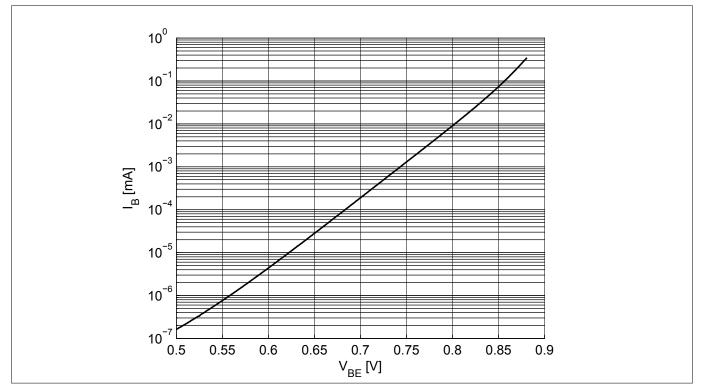


Figure 6 Base current vs. base emitter forward voltage  $I_B = f(V_{BE})$ ,  $V_{CE} = 1.8 \text{ V}$ 

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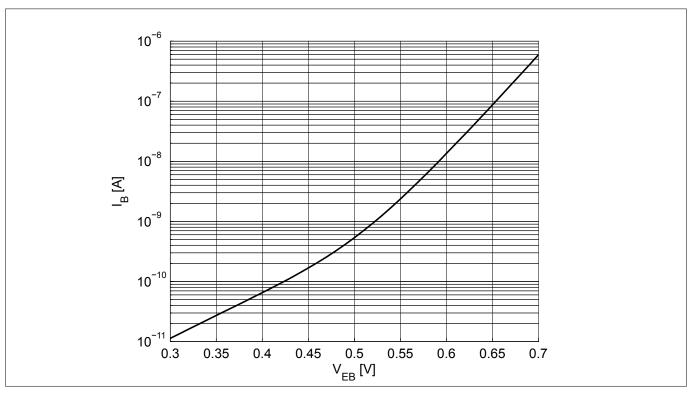


Figure 7 Base current vs. base emitter reverse voltage  $I_B = f(V_{EB})$ ,  $V_{CE} = 1.8 \text{ V}$ 



**Electrical characteristics** 

## 3.5 Characteristic AC diagrams

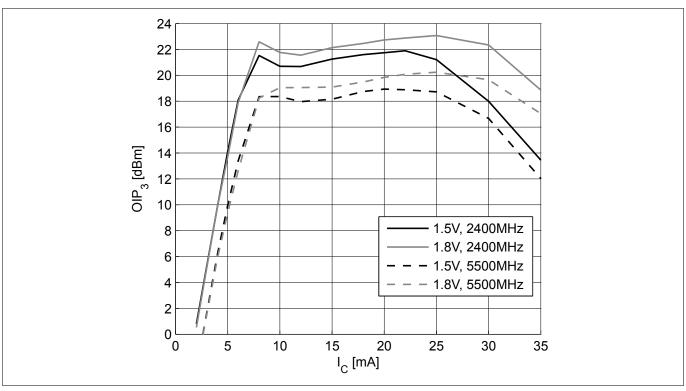


Figure 8 3rd order intercept point at output  $OIP_3 = f(I_C)$ ,  $Z_S = Z_L = 50 \Omega$ ,  $V_{CE}$ , f = parameters

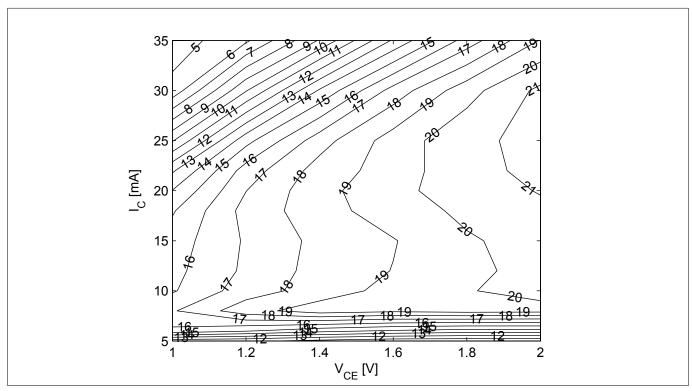


Figure 9 3rd order intercept point at output  $OIP_3$  [dBm] =  $f(I_C, V_{CE}), Z_S = Z_L = 50 \Omega, f = 5.5 \text{ GHz}$ 



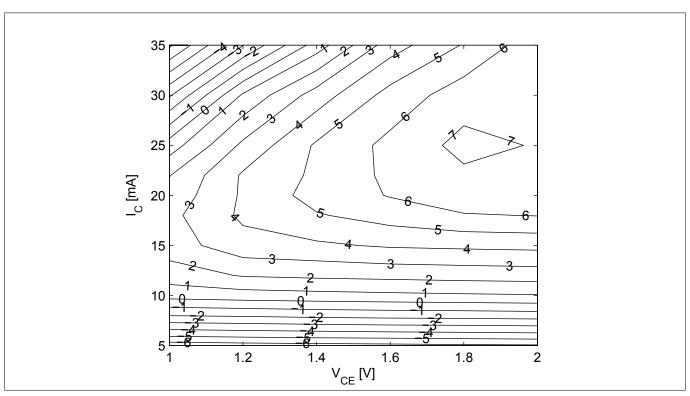


Figure 10 Compression point at output  $OP_{1dB}$  [dBm] =  $f(I_C, V_{CE}), Z_S = Z_L = 50 \Omega, f = 5.5 \text{ GHz}$ 

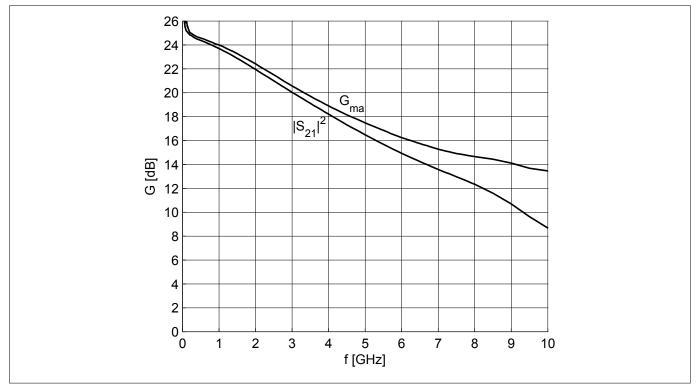


Figure 11 Gain  $G_{ma}$ ,  $IS_{21}I^2 = f(f)$ ,  $V_{CE} = 1.8 \text{ V}$ ,  $I_C = 15 \text{ mA}$ 



### **Electrical characteristics**

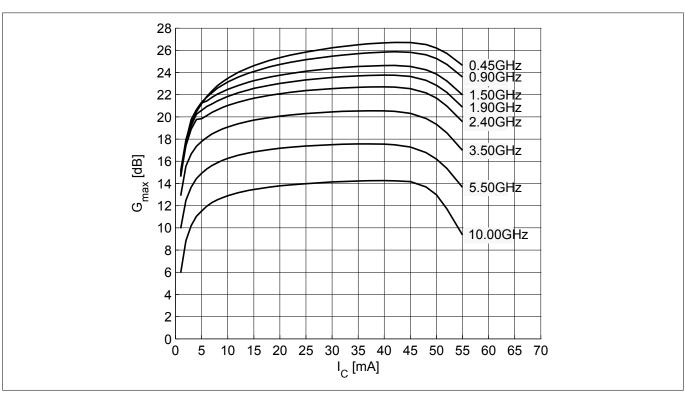


Figure 12 Maximum power gain  $G_{\text{max}} = f(I_{\text{C}})$ ,  $V_{\text{CE}} = 1.8 \text{ V}$ , f = parameter in GHz

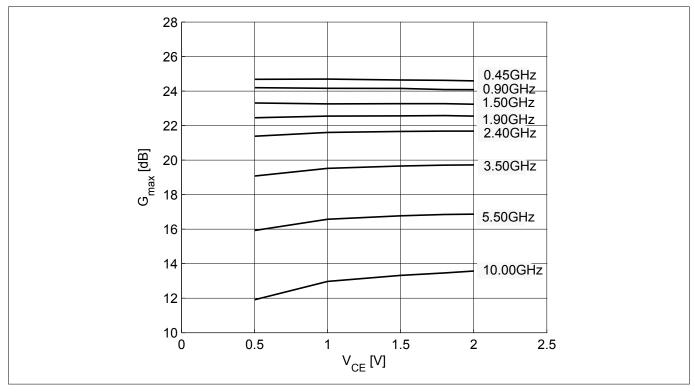


Figure 13 Maximum power gain  $G_{\text{max}} = f(V_{\text{CE}})$ ,  $I_{\text{C}} = 15 \text{ mA}$ , f = parameter in GHz



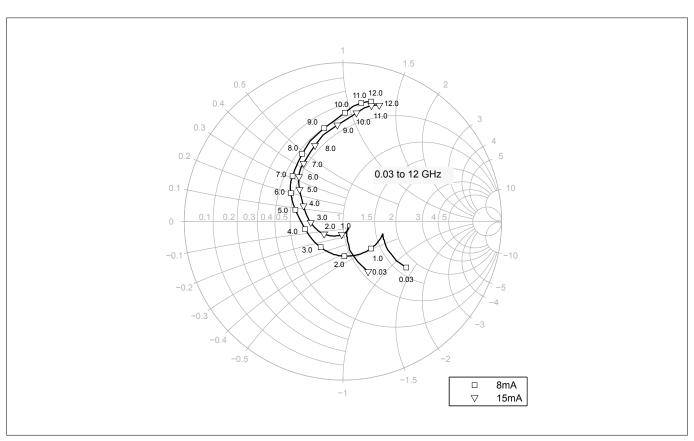


Figure 14 Input reflection coefficient  $S_{11} = f(f)$ ,  $V_{CE} = 1.8 \text{ V}$ ,  $I_{C} = 8 / 15 \text{ mA}$ 

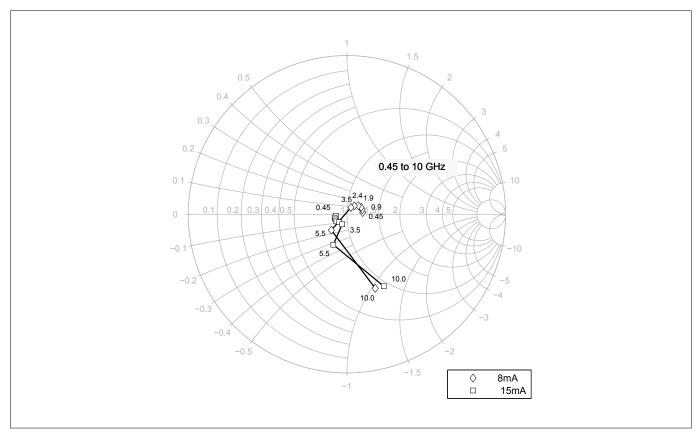


Figure 15 Source impedance for minimum noise figure  $Z_{S,opt} = f(f)$ ,  $V_{CE} = 1.8 \text{ V}$ ,  $I_C = 8 / 15 \text{ mA}$ 



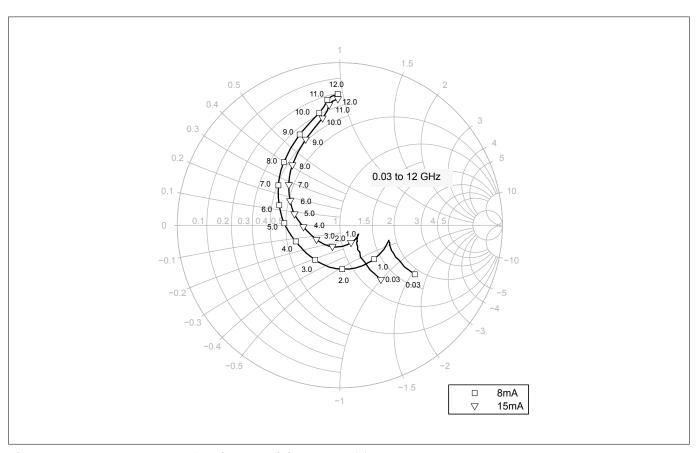


Figure 16 Output reflection coefficient  $S_{22} = f(f)$ ,  $V_{CE} = 1.8 \text{ V}$ ,  $I_C = 8 / 15 \text{ mA}$ 

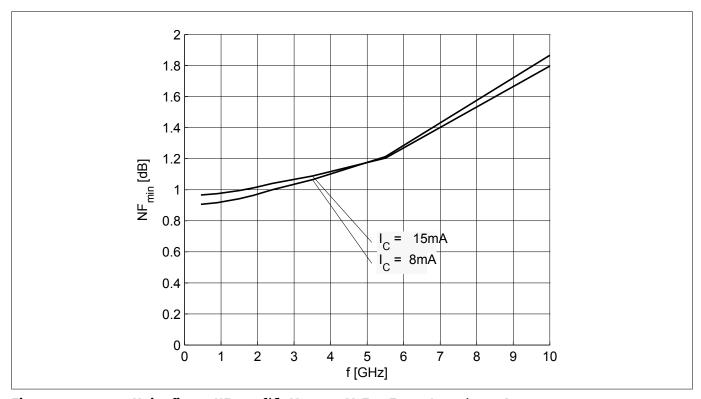


Figure 17 Noise figure  $NF_{min} = f(f)$ ,  $V_{CE} = 1.8 \text{ V}$ ,  $Z_S = Z_{S,opt}$ ,  $I_C = 8 / 15 \text{ mA}$ 



#### **Electrical characteristics**

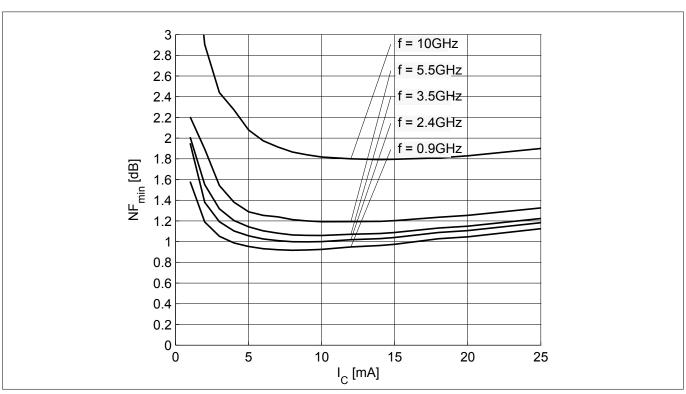


Figure 18 Noise figure  $NF_{min} = f(I_C)$ ,  $V_{CE} = 1.8 \text{ V}$ ,  $Z_S = Z_{S,opt}$ , f = parameter in GHz

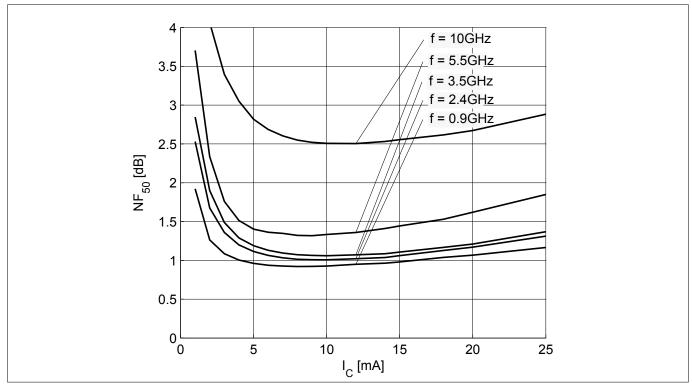


Figure 19 Noise figure  $NF_{50} = f(I_C)$ ,  $V_{CE} = 1.8 \text{ V}$ ,  $Z_S = 50 \Omega$ , f = parameter in GHz

Note: The curves shown in this chapter have been generated using typical devices but shall not be considered as a guarantee that all devices have identical characteristic curves.  $T_A = 25 \,^{\circ}\text{C}$ .



**Package information SOT343** 

# 4 Package information SOT343

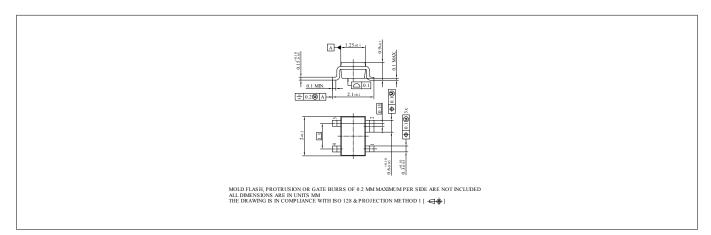


Figure 20 Package outline

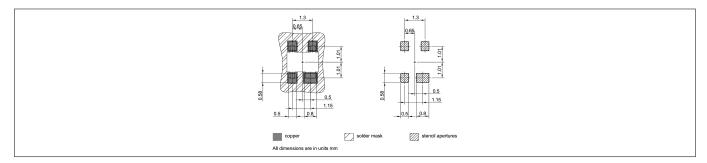


Figure 21 Foot print

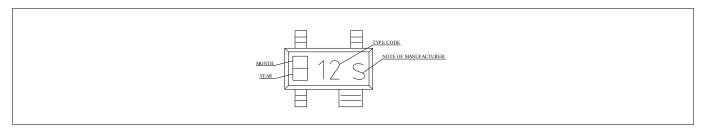


Figure 22 Marking layout example

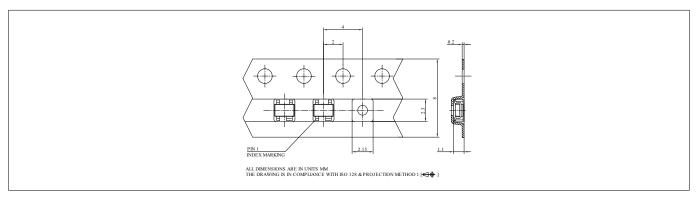


Figure 23 Tape dimensions

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**Revision history** 

# **Revision history**

Document version	Date of release	Description of changes
2.0	2018-26-09	New datasheet layout.

#### **Trademarks**

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